Se	arch Note	es ·

Application/Control No.	Applicant(s)/Patent unde Reexamination	ır
10/601,785	RADCLIFFE ET AL.	
Examiner	Art Unit	
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SEARCHED				
Clas	s	Subclass	Date	Examiner
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INTERFERENCE SEARCHED			
Class	Subclass .	Date	Examiner
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
NPL, EAST, VEPAT USPGPUB, EPO, JPO PEKWENT, IBM_TOB	3/26/51	neh		
Test search	9/10/07	W.		
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